UNISONIC TECHNOLOGIES CO., LTD

1N60Z **Power MOSFET**

1.2A, 600V N-CHANNEL **POWER MOSFET**

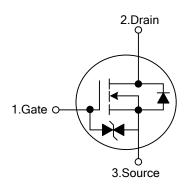
DESCRIPTION

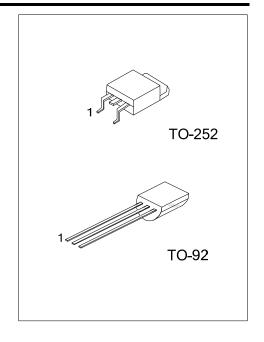
The UTC 1N60Z is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)} = 11.5\Omega@V_{GS} = 10V$.
- * Ultra Low gate charge (typical 5.0nC)
- * Low reverse transfer capacitance (C_{RSS} = typical 3.0 pF)
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL

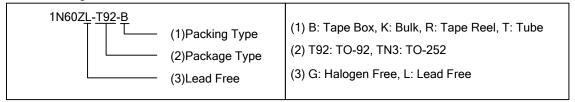




ORDERING INFORMATION

Ordering Number		Dookogo	Pin	Assignm	Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing
1N60ZL-T92-B	1N60ZG-T92-B	TO-92	G	D	S	Tape Box
1N60ZL-T92-K	1N60ZG-T92-K	TO-92	G	D	S	Bulk
1N60ZL-T92-R	1N60ZG-T92-R	TO-92	G	D	S	Tape Reel
1N60ZL-TN3-R	1N60ZG-TN3-R	TO-252	G	D	S	Tape Reel
1N60ZL-TN3-T	1N60ZG-TN3-T	TO-252	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source



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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	600	V	
Gate-Source Voltage			V_{GSS}	±20	V
Avalanche Current (Note 2)		I _{AR}	1.2	Α	
Continuous Drain Cur	rent		I _D	1.2	Α
Pulsed Drain Current	(Note 2)		I _{DM}	4.8	Α
Avalench a Francis	Single Pulsed (Note 3)		E _{AS}	50	mJ
Avalanche Energy	Repetitive (Note 2)		E _{AR}	4.0	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation ($T_A=25^{\circ}C$) $TO-92$ $TO-252$		Б	1	10/	
		O-252	P_{D}	1.5	W
Junction Temperature		TJ	+150	$^{\circ}\!\mathbb{C}$	
Operating Temperature		T _{OPR}	-55 ~ +150	$^{\circ}\mathbb{C}$	
Storage Temperature		T _{STG}	-55 ~ +150	$^{\circ}\!\mathbb{C}$	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 60mH, I_{AS} = 1A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 1.2A$, $di/dt \le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
lumation to Ameliant	TO-92		140	°C 001
Junction to Ambient	TO-252	θ_{JA}	100	°C/W

■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified.)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250μA	600			V	
Drain-Source Leakage Current		I _{DSS}	V _{DS} =600V, V _{GS} =0V			10	μΑ	
Gate-Source Leakage Current	Forward	I _{GSS}	V_{GS} =20V, V_{DS} =0V			+5	μΑ	
	Reverse		V _{GS} =-20V, V _{DS} =0V			-5	μΑ	
Breakdown Voltage Temperature	Coefficient	$\triangle BV_{DSS}/\triangle T_{J}$	I _D =250μA		0.4		V/°C	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =0.6A		9.3	11.5	Ω	
DYNAMIC CHARACTERISTICS								
Input Capacitance		C _{ISS}			120	150	pF	
Output Capacitance		Coss	V_{DS} =25V, V_{GS} =0V, f=1MHz		20	25	pF	
Reverse Transfer Capacitance		C _{RSS}			3.0	4.0	pF	
SWITCHING CHARACTERISTIC	S							
Turn-On Delay Time		t _{D(ON)}			5	20	ns	
Turn-On Rise Time		t_R	V_{DD} =300V, I_{D} =1.2A, R_{G} =50 Ω		25	60	ns	
Turn-Off Delay Time		t _{D(OFF)}	(Note 2,3)		7	25	ns	
Turn-Off Fall Time		t _F			25	60	ns	
Total Gate Charge		Q_{G}	\/ -490\/ \/ -10\/		5.0	6.0	nC	
Gate-Source Charge		Q_GS	V _{DS} =480V, V _{GS} =10V,		1.0		nC	
Gate-Drain Charge		Q_{GD}	I _D =1.2A (Note 2,3)		2.6		nC	

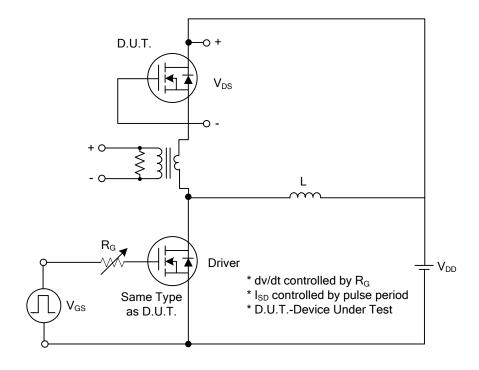
■ **ELECTRICAL CHARACTERISTICS** (T_C=25°C, unless otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS								
Drain-Source Diode Forward Voltage	V_{SD}	V_{GS} =0 V , I_S =1.2 A			1.4	V		
Maximum Continuous Drain-Source Diode Forward Current	Is				1.2	Α		
Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}				4.8	Α		
Reverse Recovery Time	t _{rr}	V _{GS} =0V, I _S =1.2A		160		ns		
Reverse Recovery Charge	Q_{RR}	dI _F /dt=100A/µs (Note 1)		0.3		μC		

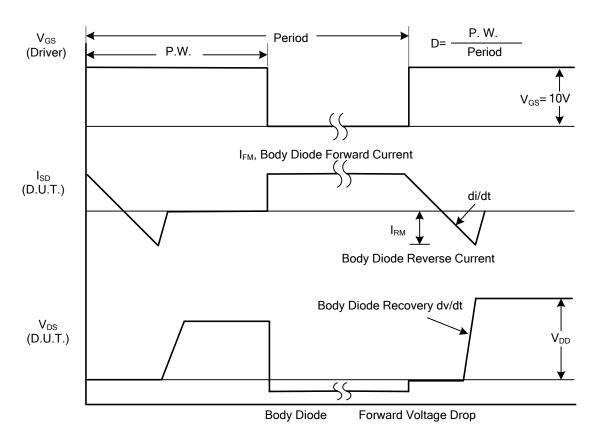
Note:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. Pulse Test: Pulse Width ≤300µs, Duty Cycle≤2%
- 3. Essentially Independent of Operating Temperature

■ TEST CIRCUITS AND WAVEFORMS

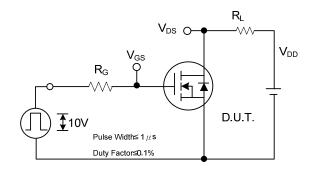


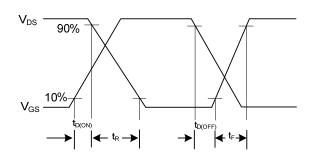
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

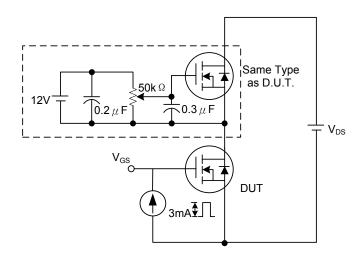
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

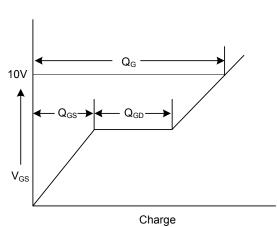




Switching Test Circuit

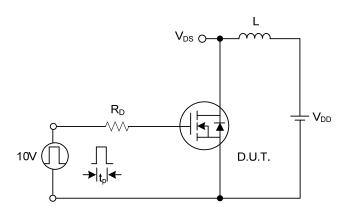
Switching Waveforms

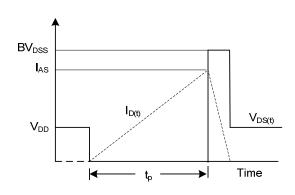




Gate Charge Test Circuit

Gate Charge Waveform

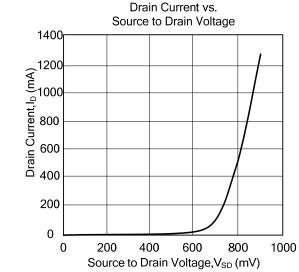


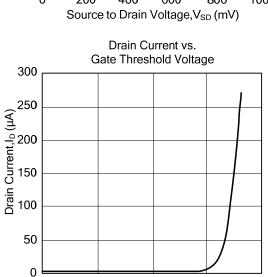


Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

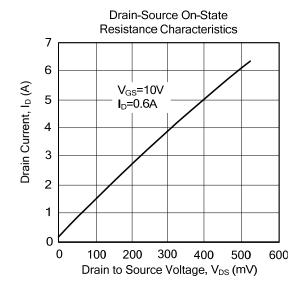
■ TYPICAL CHARACTERISTICS

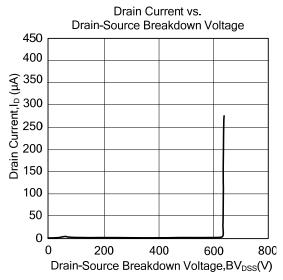




1 2 3 Gate Threshold Voltage,V_{TH} (V)

0





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